## . . . Application/Control No. Applicant(s)/Patent Under Reexamination 10/791,753 FUJIMURA, TSUTOMU Notice of References Cited Examiner Art Unit Page 1 of 1 Patricia Leith 1655 **U.S. PATENT DOCUMENTS** Document Number Date Name Country Code-Number-Kind Code Classification MM-YYYY US-Α В US-US-С D US-US-Е US-F US-G US-Н ı US-US-J US-Κ US-L US-**FOREIGN PATENT DOCUMENTS** Document Number Date Country Code-Number-Kind Code Country Name Classification MM-YYYY JP02000344655A UDA et al 12-2000 0 Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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